## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination LAUER ET AL. | Examiner | Art Unit | Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0178897	09-2004	Fennel et al.	340/442
*	В	US-6,802,213	10-2004	Agrotis, Demetris Andreou	73/146
*	C	US-6,731,205	05-2004	Schofield et al.	340/444
*	D	US-6,446,023	09-2002	Ernst, Gerhard	702/138
*	E	US-6,014,599	01-2000	Inoue et al.	701/29
*	F	US-2005/0253696	11-2005	Mori et al.	340/445
*	G	US-2005/0044946	03-2005	Agrotis, Demetris Andreou	073/146.5
*	H	US-2002/0130771	09-2002	Osborne et al.	340/438
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	ď					
	R					
	S					
	Τ					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.